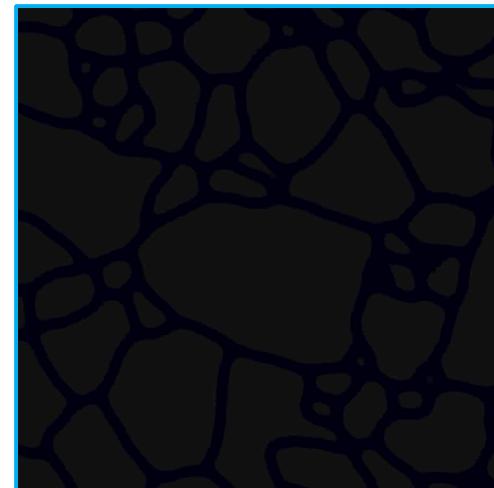
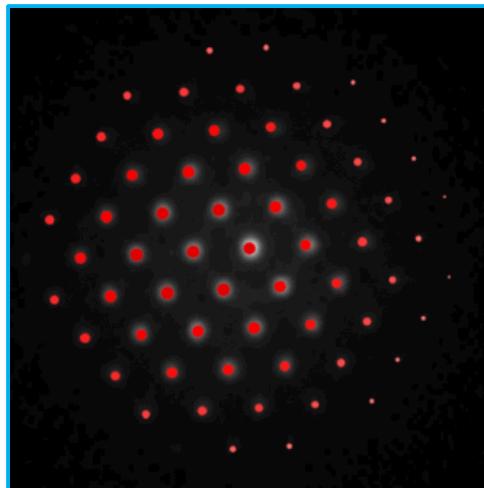
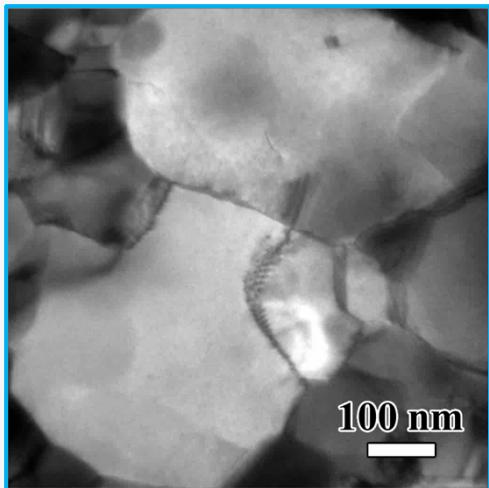




# Irradiation-Induced Grain Growth: Local Orientation Characterization and Coordinated Modeling



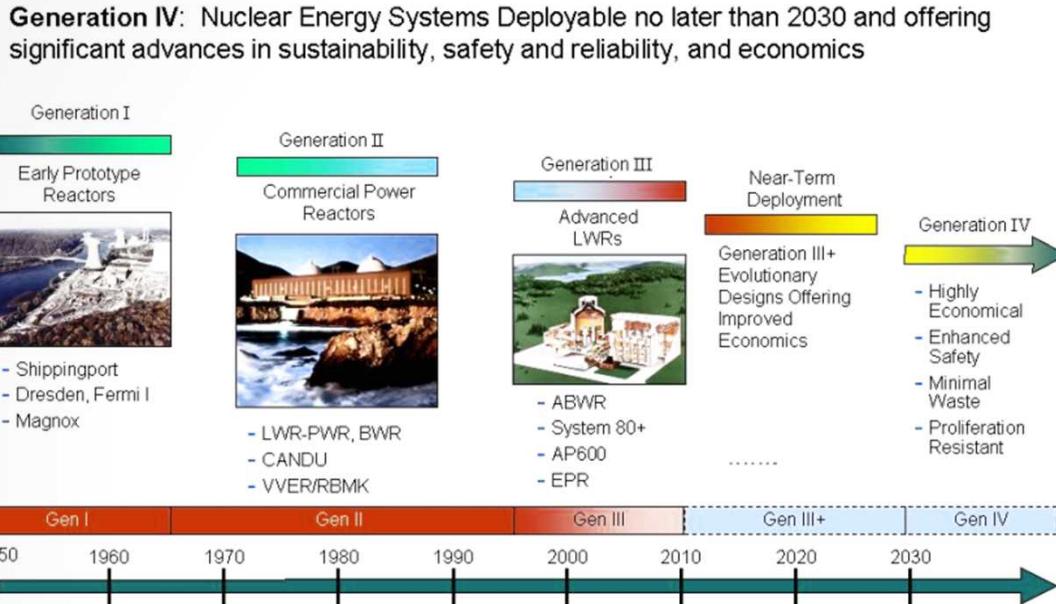
Daniel C. Bufford, Fadi F. Abdeljawad, Stephen M. Foiles, and Khalid Hattar  
Sandia National Laboratories



Sandia National Laboratories is a multi-program laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-AC04-94AL85000. SAND NO. 2014-4330C

# Motivation

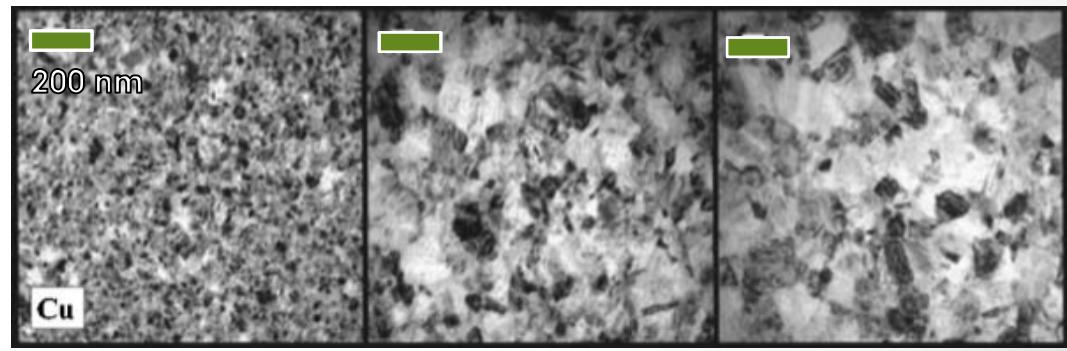
Argonne National Lab, via Wikimedia Commons.



Aleš Buršić, via World-Nuclear-News.org

## Nanocrystalline metals

- Exemplary mechanical properties
- Abundant sinks for structural and chemical defects
- Ideal candidates for radiation-tolerant materials?



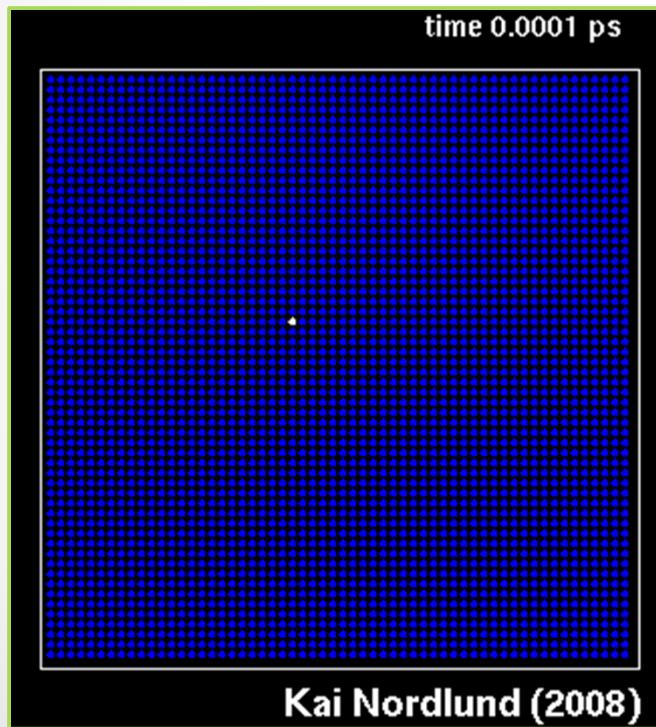
Kaoumi, et al, J ASTM Int, 2006

What are the relationships among ion damage, grain boundary character, and grain growth?

# Radiation-Solid Interactions

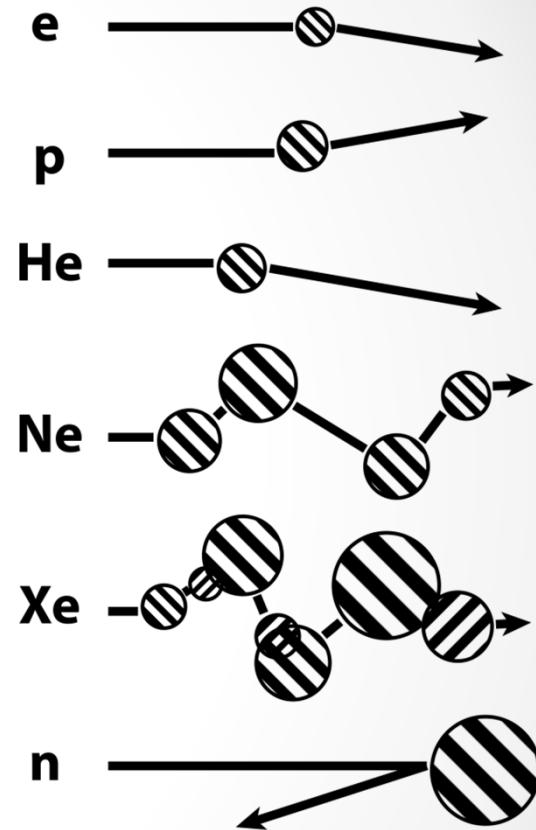


- Energetic ion displaces one or more target atoms
  - Frenkel (vacancy-interstitial) pair
  - Collision cascade
  - Nuclear and electronic interactions



Effective transient temperatures  
~thousand(s) of K!

Affected volumes vary based on radiation species, energy, and target material.



Schematic recoil spectra for 1 MeV particles in Cu. Sizes represent recoil energies. After Averback, J Nucl Mater, 1994.

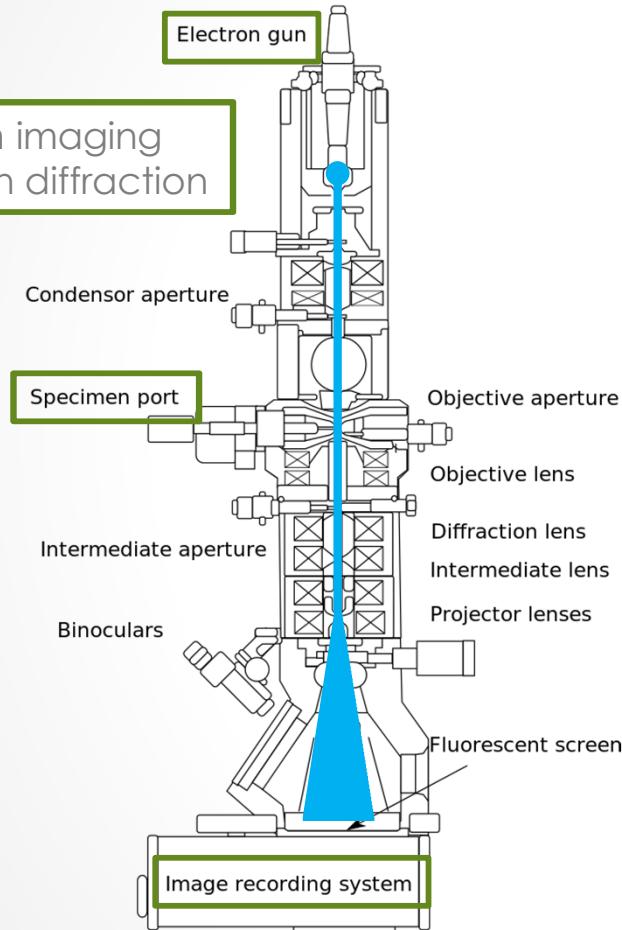
Highly temporally and spatially localized energy transfer drives microstructural change.

# Sandia's *In situ* Ion Irradiation TEM (I<sup>3</sup>TEM)

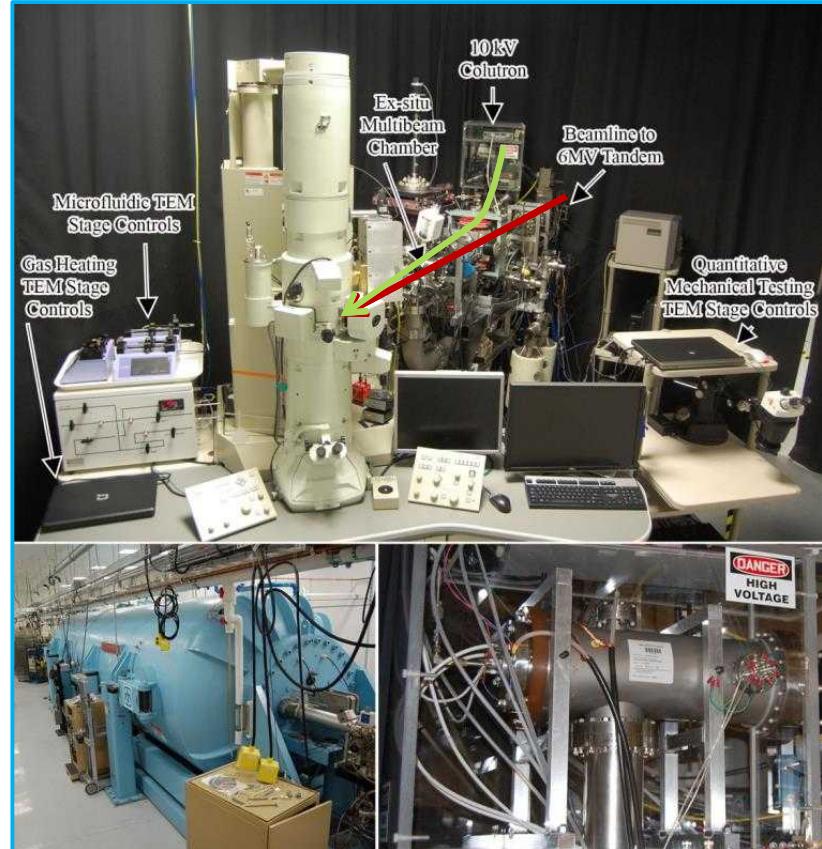


Collaborator: D.L. Buller

10 kV Colutron - 200 kV TEM - 6 MV Tandem



Gringer, 2009, via Wikimedia Commons.



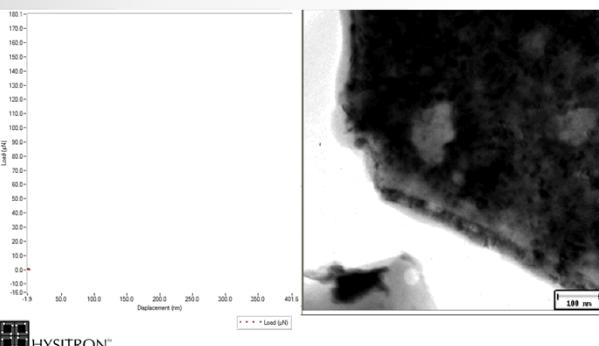
Hattar, et al, Nucl Instr Meth Phys Res B, 2014.

Enables real-time studies of samples under irradiation.

# Synergistic In Situ Capabilities



## Mechanical



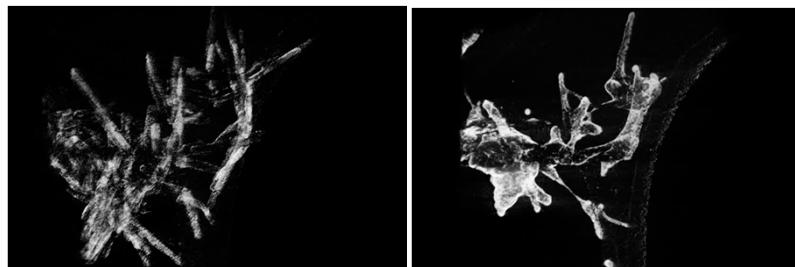
### Hysitron PI95 TEM Picoindenter Gatan 654 Straining Holder

Direct correlation of dose and defect density with resulting changes in strength, ductility, and defect mobility

## Structural

### Hummingbird Tomography Stage Gatan 925 Double Tilt Rotate

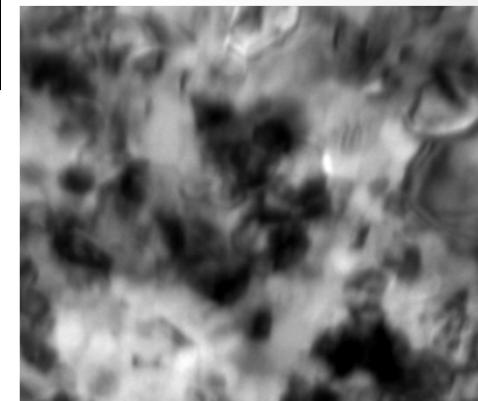
Morphology changes as a result of radiation damage



## Thermal

### Hummingbird Heating Stage

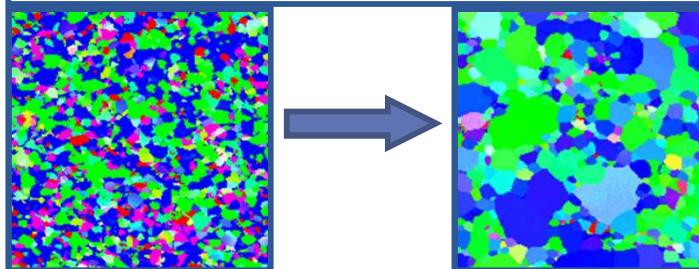
Coupling effects of temperature and irradiation on microstructural evolution up to 800 °C



## Texture

### Nanomegas ASTAR

Quantifying orientation changes as a result of radiation, implantation, and heat.



## Environmental

### Protopchips Liquid and Gas Flow

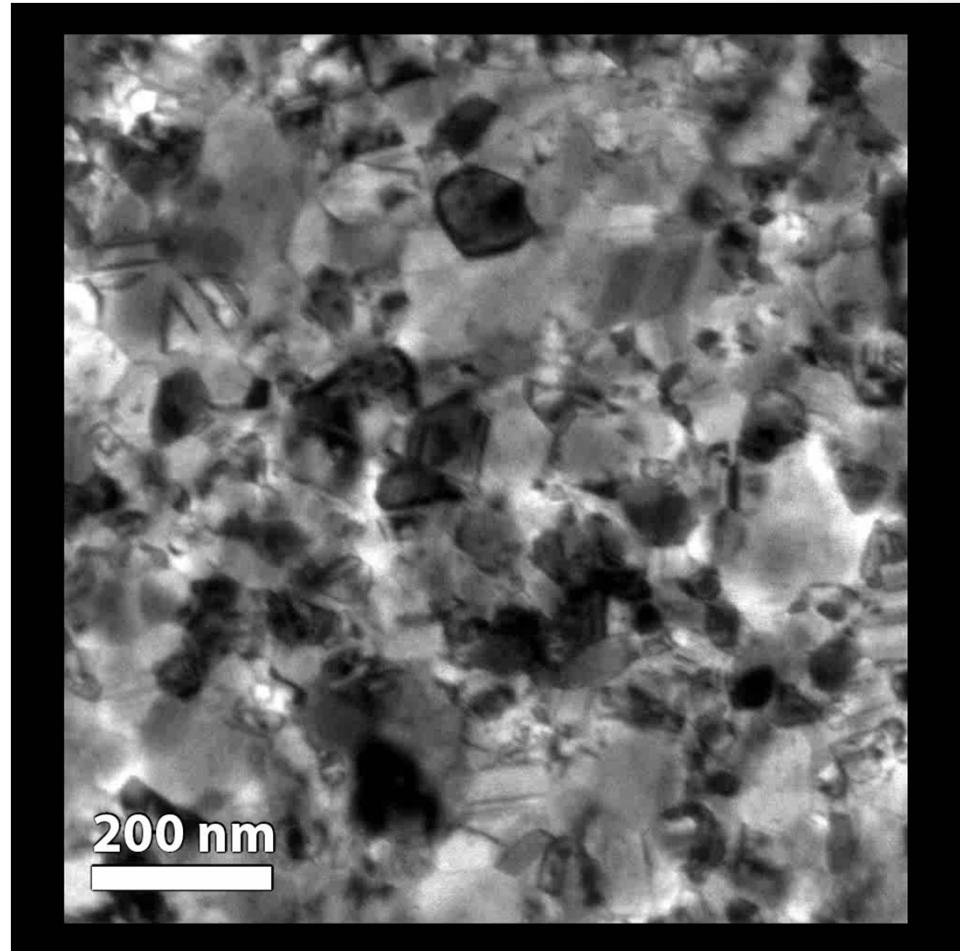
Effects of radiation on corrosion and gas loading at the grain level

The application of advanced microscopy techniques to characterize synergistic effects in a variety of extreme environments

# *In Situ* Irradiation

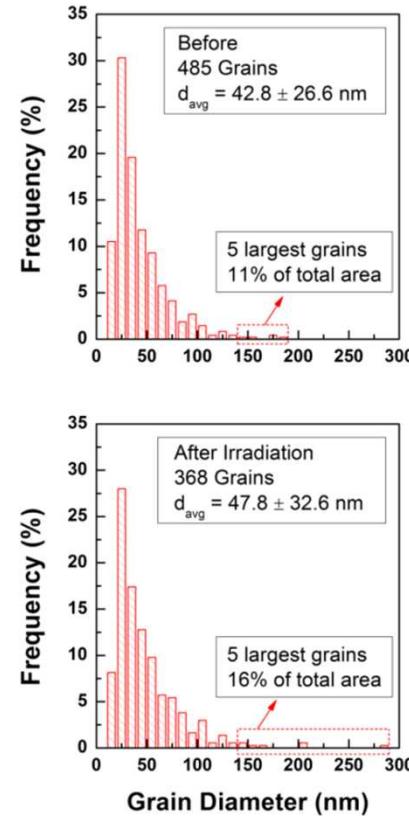
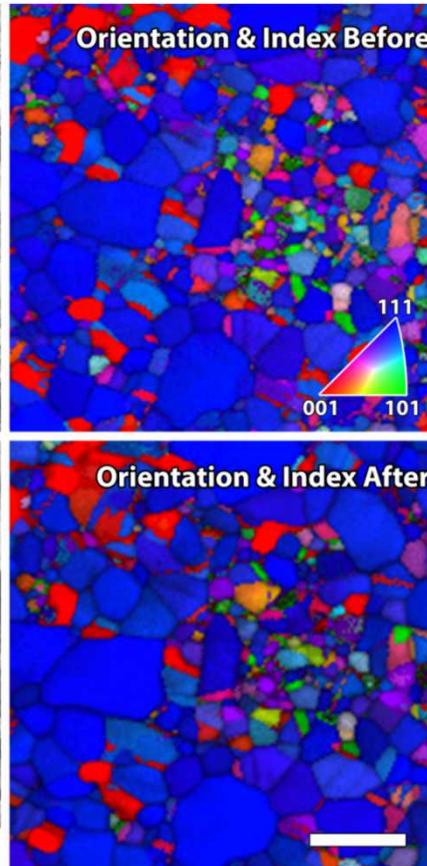
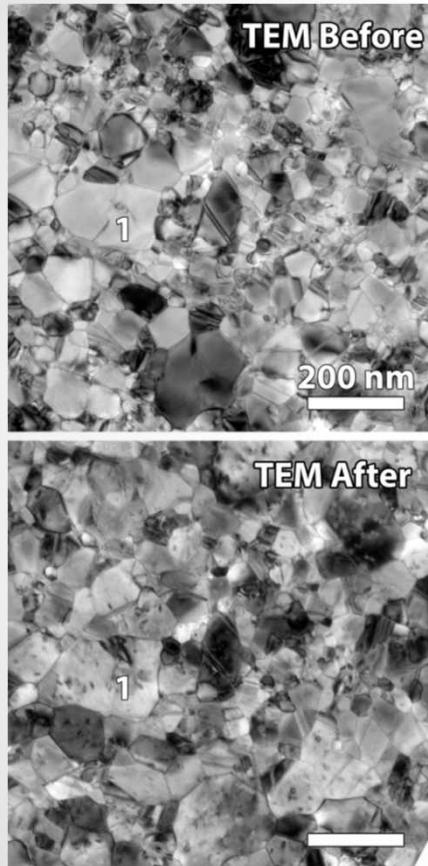


- Au foil during bombardment with 10 MeV Si<sup>3+</sup>
- ~10 s of 4000s total experiment time
- Can reproduce previous results, but with greater energy range and expanded capabilities for analysis.



Locations of single ion strikes and resulting microstructural change captured.

# Quantification: Statistical

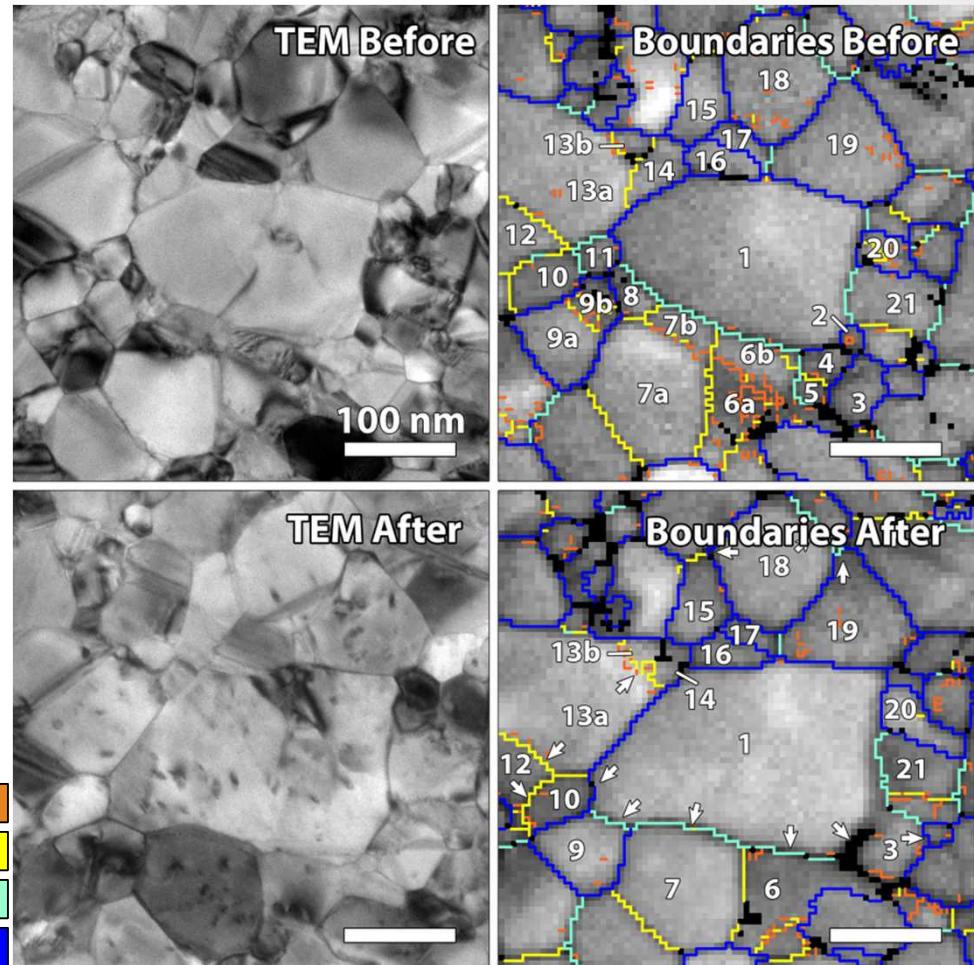
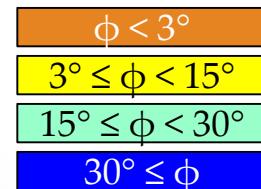


- Same area characterized before and after irradiation.
- Standard TEM
- Orientation maps
  - Local grain size, orientation, boundary character
  - Hundreds of grains counted in minutes

Rapid quantification of statistically relevant numbers of grains and boundaries.

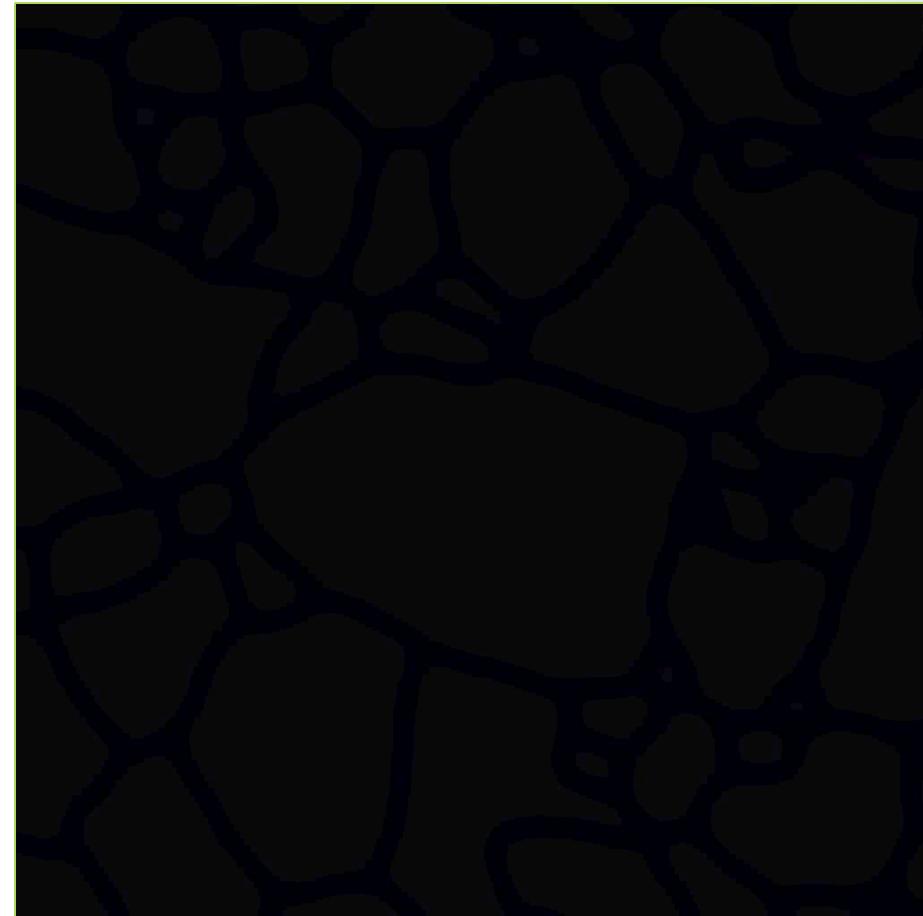
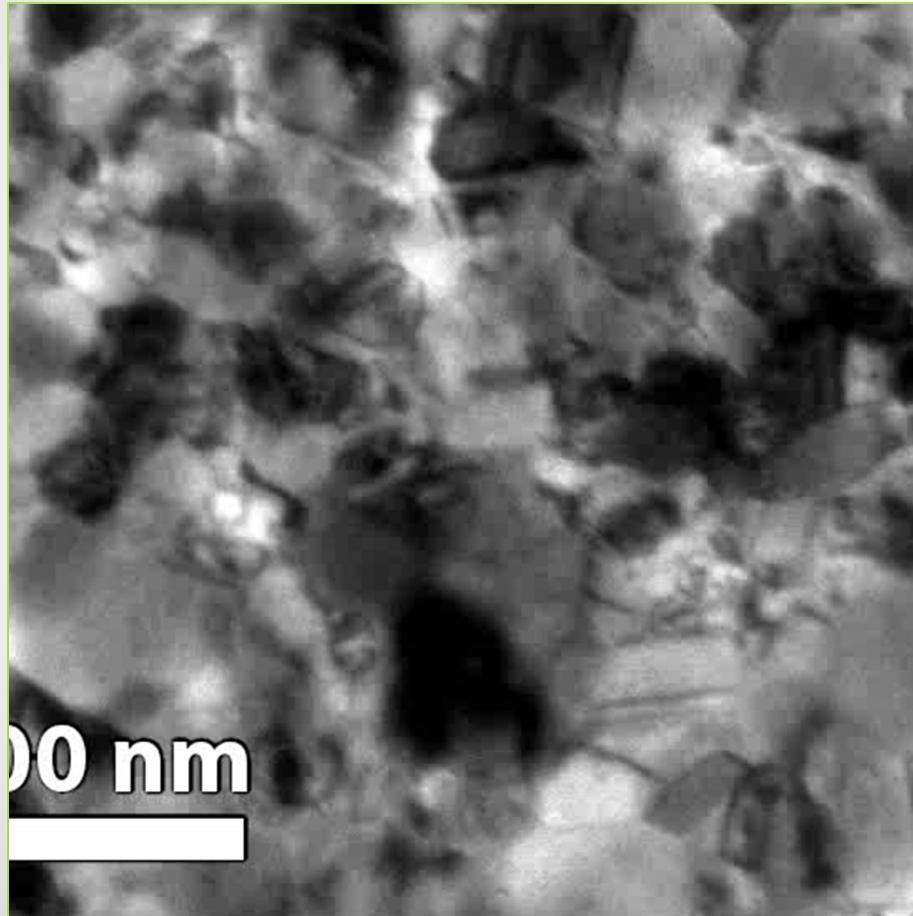
# Quantification: Local

- The same grains identified before and after irradiation
- Individual grain boundary misorientation angles and axes quantified
- Correlation of GB properties and radiation-induced changes

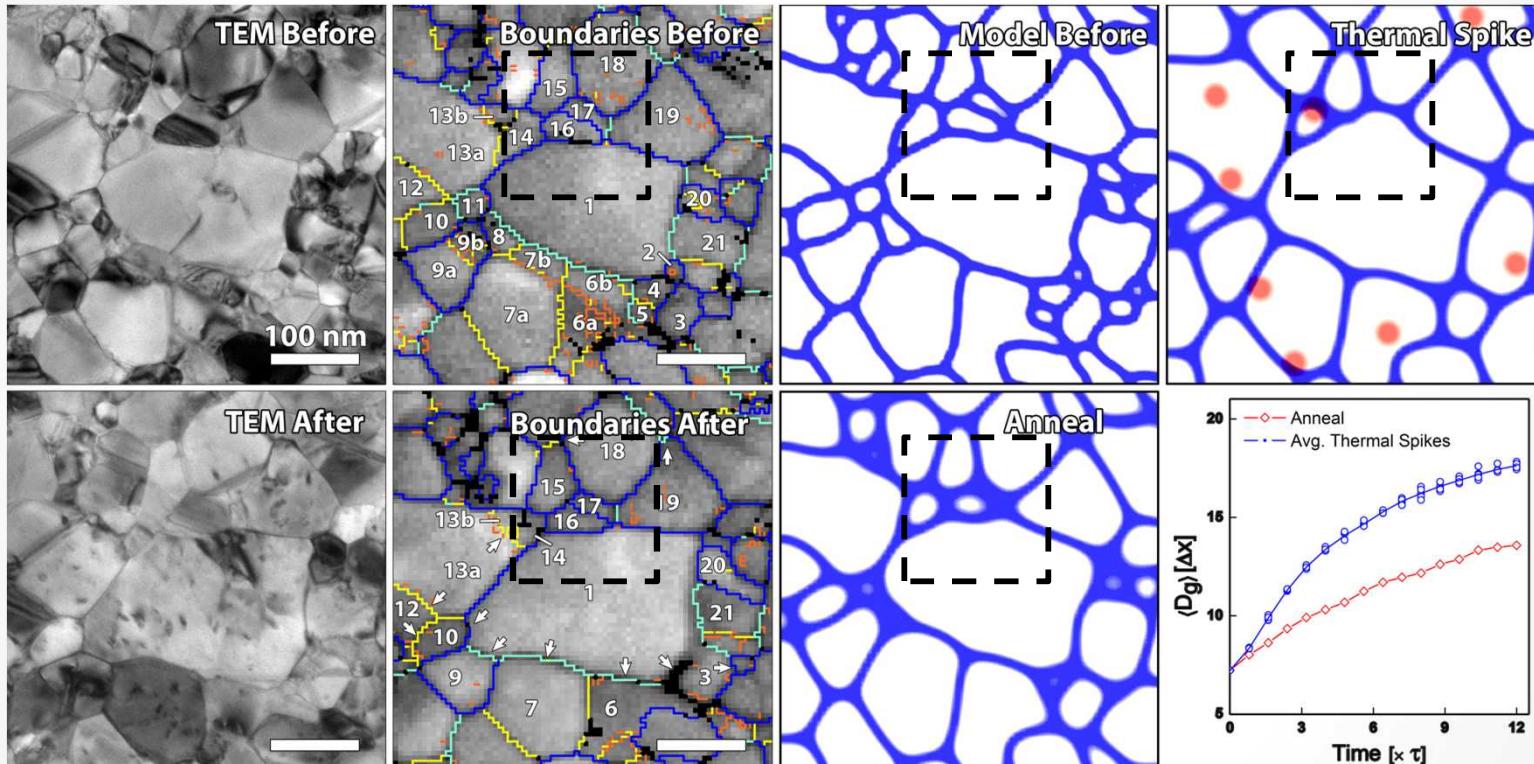


Grain boundary misorientation angle and axes quantified

# Simulated Irradiation



# Experiment/Model Discrepancies?

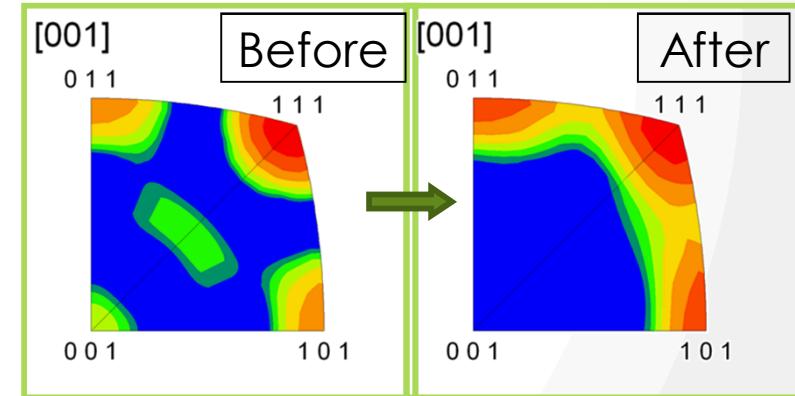


- Subtle deviations from homogenous grain growth
- Overall scaling laws appear consistent

Immobile boundaries suggest importance of non-thermally activated mobility

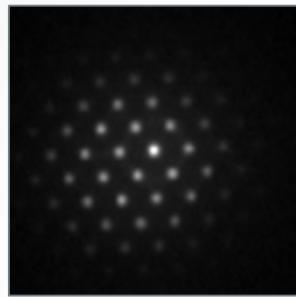
# Summary

- TEM orientation mapping at various ion fluences
  - Analyzed and used as direct input for a phase field model
- Discrepancies between experimentally observed and modeled grain growth
- Stable grains are characteristic of known low mobility grains

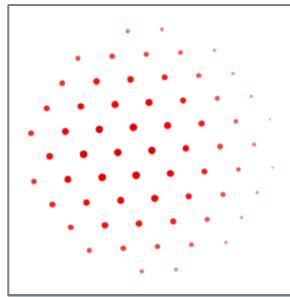


- Acknowledgements: A. Darbal (AppFive), D. Kaoumi (University of South Carolina), A. Leff (Drexel University), and B.L. Boyce, D.L. Boller, C. Gong, H. Lim, M.T. Marshall, and B.R. Muntifering (Sandia National Laboratories). This work was fully supported by the Division of Materials Science and Engineering, Office of Basic Energy Sciences, U.S. Department of Energy.

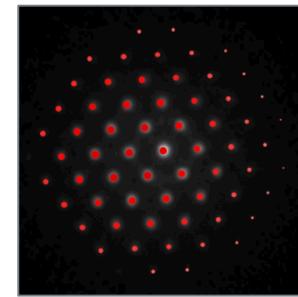
# Approach: Experimental



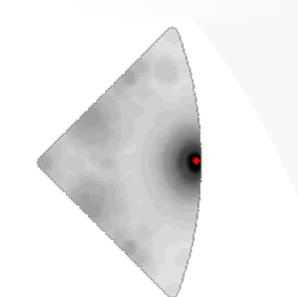
Experimental  
Pattern



Theoretical  
Template

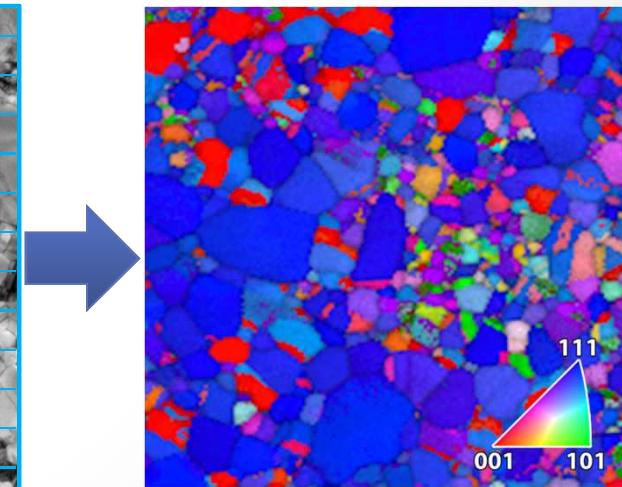
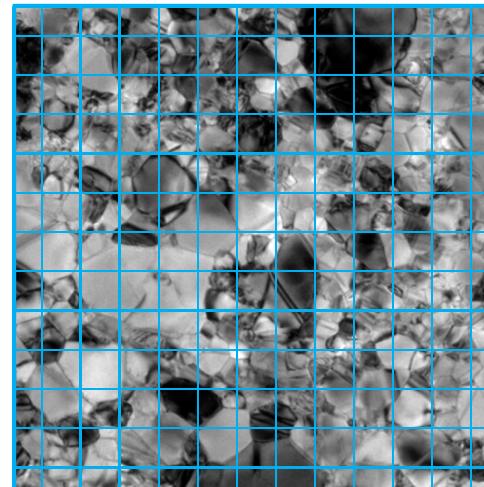


Template  
Matched



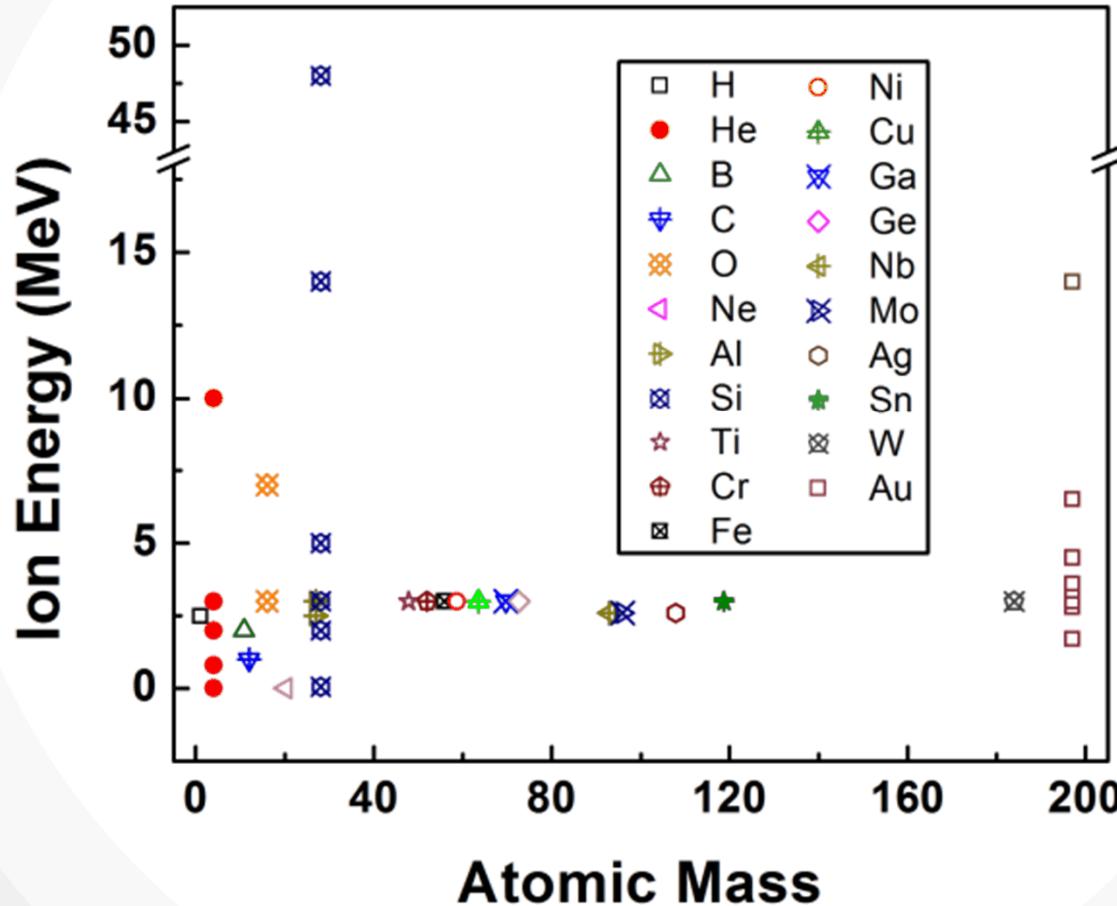
Point Mapped  
To IPF

- Automated diffraction orientation mapping
  - Point by point grid of orientations mapped
  - 5 nm resolution
- Analogous to EBSD



Point diffraction data

# Ions in the TEM

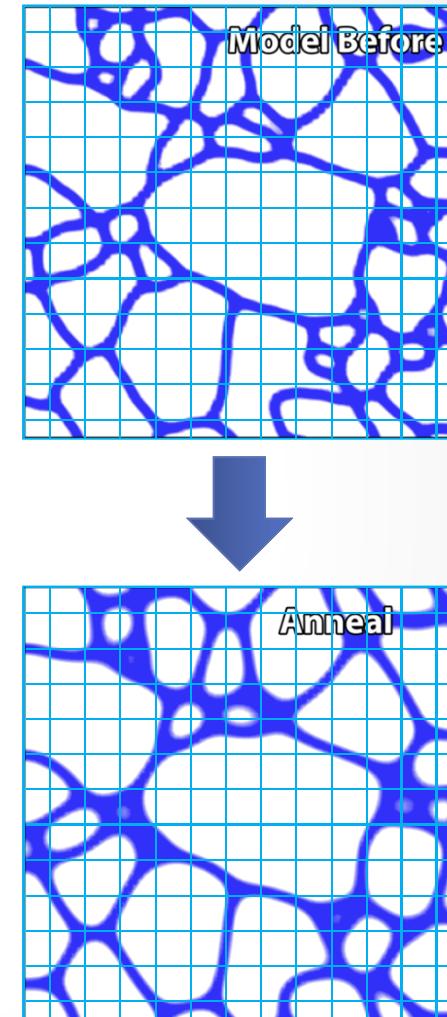


Hattar, *et al*, Nucl Instr Meth Phys Res B, 2014.

# Approach: Modeling

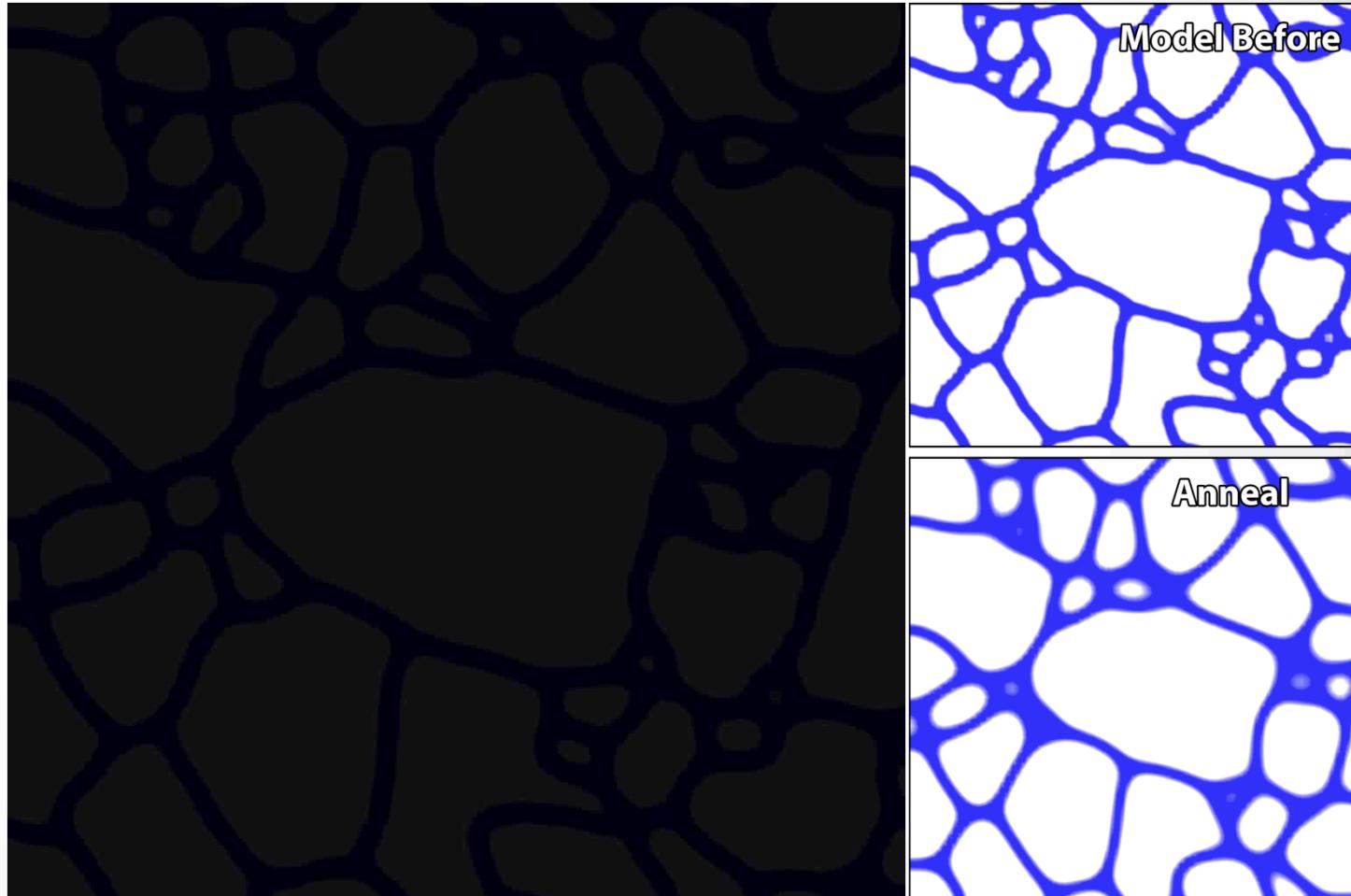


- What is phase field modeling?
  - Mathematical model for solving interfacial problems, like solidification, growth, etc.
- Example grain growth model
  - Thermodynamic free energy function
    - $dF = d(\gamma A) = \gamma dA$  ( $\gamma$ : GB energy,  $A$ : GB area)
  - Model for kinetics
    - $V = M\gamma h$  ( $M$ : GB mobility,  $h$ : GB curvature)
  - Solve at each pixel for a predetermined timestep
- See Abdeljawad and Foiles, Acta Mater, 2015 for more information



Can directly use experimental maps as input structures, and then compare evolutions!

# Simulated Anneal



# Model Data Analysis



- During simulated annealing grain growth scales approximately with  $T^{1/2}$ 
  - Expected for homogenous grain growth
- During simulated irradiation, grain growth scales with  $T^{1/n}$ , where  $n \approx 3$ 
  - Initially faster, but stagnates sooner

